

Notice of References Cited	Application/Control No. 10/785,153	Applicant(s)/Patent Under Reexamination ISHIKAWA ET AL.	
	Examiner Seung H. Lee	Art Unit 2876	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2004/0041022 A1	03-2004	Minowa et al.	235/383
	C	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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